

<b>Notice of References Cited</b>	Application/Control No. 10/701,516	Applicant(s)/Patent Under Reexamination LIU, I-WEN	
	Examiner David T. Fidei	Art Unit 3728	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,686,776	08-1987	Matsubara, Mamoru	34/95
*	B	US-4,987,267	01-1991	Takaoka et al.	568/615
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	09-141091	06-1997	Japan	Yohei	
	O	2002-332072	11-2002	Japan	Yuichi	
	P	09-141091	06-1997	Japan	Patent Translation <i>(partial)</i>	10 pages
	Q	2002-332072	11-2002	Japan	Patent Translation <i>(partial)</i>	17 pages
	R	09-215648	08-1997	Japan	Patent Abstracts <i>TRANSLATION</i>	2 pages
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.